

WNM2021

N-Channel, 20V, 0.89A, Small Signal MOSFET

V _{DS} (V)	Rds(on) (Ω)	I _D (A)
	0.220@ V _{GS} =4.5V	0.55
20	0.260@ V _{GS} =2.5V	0.45
	0.320@ V _{GS} =1.8V	0.35

Descriptions

The WNM2021 is N-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent $R_{\text{DS }(\text{ON})}$ with low gate charge. This device is suitable for use in DC-DC conversion, load switch and level shift. Standard Product WNM2021 is Pb-free.

Features

- Trench Technology
- Supper high density cell design
- Excellent ON resistance
- Extremely Low Threshold Voltage
- Small package SOT-323

Applications

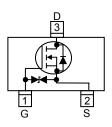
- DC-DC converter circuit
- Small Signal Switch
- Load Switch
- Level Shift

lacktriangle

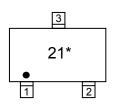
Http//:www.willsemi.com



SOT-323



Pin configuration (Top view)



21 = Device Code

* = Month ($A \sim Z$)

Marking

Order information

Device	Package	Shipping
WNM2021-3/TR	SOT-323	3000/Reel&Tape



Absolute Maximum ratings

Parameter		Symbol	10 S	Steady State	Unit	
Drain-Source Voltage		V_{DS}	20		V	
Gate-Source Voltage		V_{GS}	±6		v	
Continuous Drain Current ^a	T _A =25°C		0.89	0.82	А	
Continuous Diain Current	T _A =70°C	- I _D	0.71	0.65		
Maximum Power Dissipation ^a	T _A =25°C	В	0.37	0.31	W	
iwaximum Fower Dissipation	T _A =70°C	P _D	0.23	0.20		
Continuous Drain Current b	T _A =25°C	I _D	0.78	0.70	Α	
Continuous Drain Current	T _A =70°C		0.62	0.56		
Maximum Power Dissipation ^b	T _A =25°C	P _D	0.29	0.23	W	
Maximum Power Dissipation	T _A =70°C		0.18	0.14		
Pulsed Drain Current ^c		I _{DM}	1.4		А	
Operating Junction Temperature		T_J	150		°C	
Lead Temperature		T _L	260		°C	
Storage Temperature Range		T _{stg}	-55 to 150		°C	

Thermal resistance ratings

Parameter	Symbol	Typical	Maximum	Unit	
Junction-to-Ambient Thermal Resistance ^a	t ≤ 10 s	$R_{\theta JA}$	275	335	
Juniction-to-Ambient Mermai Resistance	Steady State		325	395	
lunction to Ambient Thermal Desistance	t ≤ 10 s	$R_{\theta JA}$	375	430	°C/W
Junction-to-Ambient Thermal Resistance ^b	Steady State		445	535	
Junction-to-Case Thermal Resistance	Steady State	$R_{ heta JC}$	260	300	

- a Surface mounted on FR4 Board using 1 square inch pad size, 1oz copper
- b Surface mounted on FR4 board using minimum pad size, 1oz copper
- c Repetitive rating, pulse width limited by junction temperature, t_p=10µs, Duty Cycle=1%
- d Repetitive rating, pulse width limited by junction temperature T_J=150°C.

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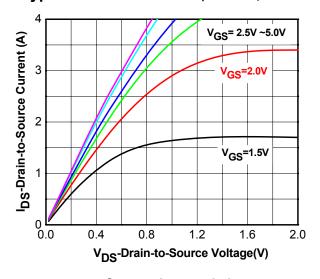
Electronics Characteristics (Ta=25°C, unless otherwise noted)

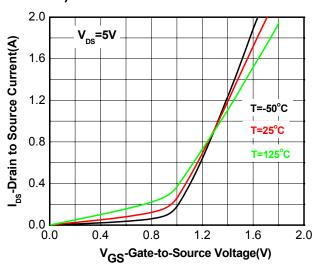
Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit	
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0 V, I _D = 250uA				V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =16 V, V _{GS} = 0V			100	nA	
Gate-to-source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =±5V			5	uA	
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 250uA$	0.45	0.58	0.85	V	
		VGS = 4.5V, ID = 0.55A		220	260	1	
Drain-to-source On-resistance	R _{DS(on)}	VGS = 2.5V, ID = 0.45A		260	310	mΩ	
		VGS = 1.8V, ID = 0.35A		320	380		
Forward Transconductance	g FS	VDS = 5 V, ID = 0.55A		2.0		S	
CHARGES, CAPACITANCES AND G	ATE RESISTA	ANCE					
Input Capacitance	C _{ISS}			50		pF	
Output Capacitance	Coss	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz, } V_{DS} = 1.0 \text{ V}$		13			
Reverse Transfer Capacitance	C _{RSS}	10 V		8			
Total Gate Charge	$Q_{G(TOT)}$			1.15			
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V},$		0.06		nC	
Gate-to-Source Charge	Q _{GS}	I _D = 0.55A		0.15			
Gate-to-Drain Charge	Q_{GD}			0.23			
SWITCHING CHARACTERISTICS					•		
Turn-On Delay Time	td(ON)			22			
Rise Time	tr	V _{GS} = 4.5 V, V _{DS} = 10V,		80		ns	
Turn-Off Delay Time	td(OFF)	R_L =3 Ω, R_G =6 Ω		700			
Fall Time	tf			380		<u> </u>	
BODY DIODE CHARACTERISTICS							
Forward Voltage	V _{SD}	$V_{GS} = 0 \text{ V}, I_{S} = 0.35 \text{A}$	0.5	0.7	1.1	V	

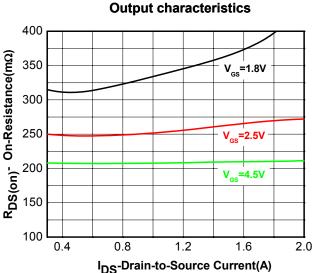
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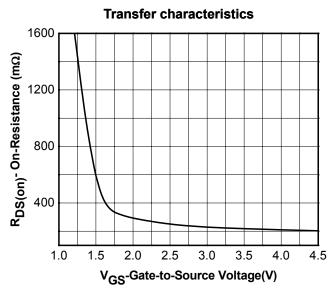


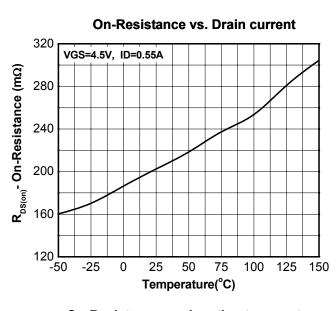
Typical Characteristics (Ta=25°C, unless otherwise noted)

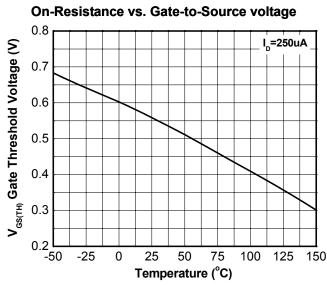








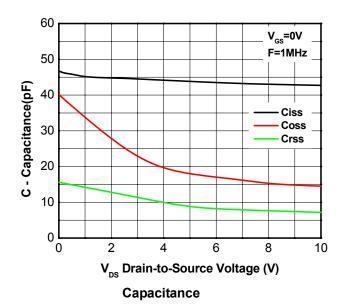


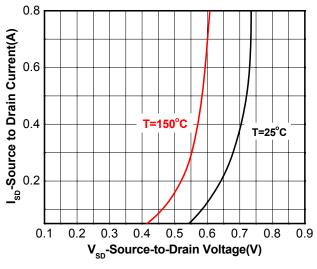


On-Resistance vs. Junction temperature

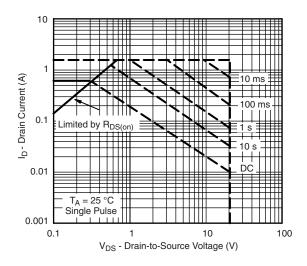
Threshold voltage vs. Temperature



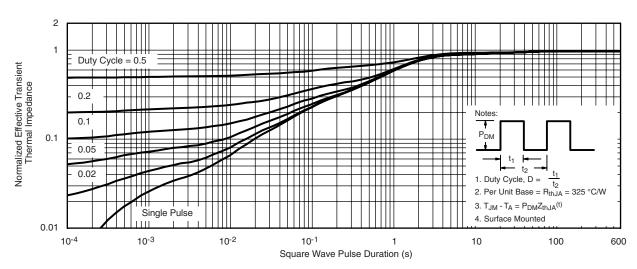




Body diode forward voltage



Safe operating power



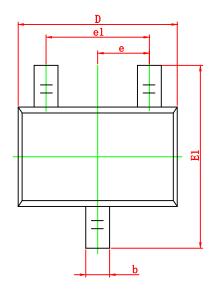
Transient thermal response (Junction-to-Ambient)

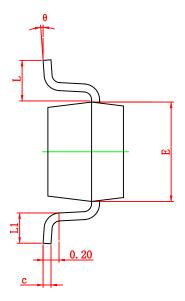
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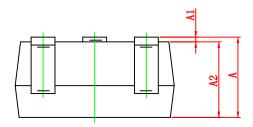


Package outline dimensions

SOT-323







Compleal	Dimensions in millimeter				
Symbol	Min.	Тур.	Max.		
A	0.900	1.000	1.100		
A1	0.000	0.050	0.100		
A2	0.900	0.950	1.000		
b	0.200	0.300	0.400		
С	0.080	0.115	0.150		
D	2.000	2.100	2.200		
E	1.150	1.250	1.350		
E1	2.150	2.300	2.450		
е		0.650TYP			
e1	1.200	1.300	1.400		
L		0.525REF			
L1	0.260		0.460		
θ	0°		8°		